Application/Control No. O9/177,572 Applicant(s)/Patent Under Reexamination TERASHIMA ET AL. Examiner Kevin M. Nguyen Applicant(s)/Patent Under Reexamination TERASHIMA ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-4,864,402	09-1989	Ebihara et al	358/160
	В	US-5,905,483	05-1999	Yuki	345/98
	С	US-6,115,020	09-2000	Taguchi et al	345/99
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	K	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	. Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	х	(C. MDED S 707 OF (s.))

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.